

135169



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent application of:

Chester L. Shepard et al

Serial No. 09/870,332

May 30, 2001

SYSTEM AND METHOD FOR GLASS
PROCESSING AND TEMPERATURE
SENSING

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Before the Examiner

Not Yet Assigned

July 17, 2001

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to the Assistant Commissioner for Patents, Washington, D.C. 20231 on July 17, 2001.

John M. Bradshaw

Name of Registered Representative

Signature

Date of Signature

INFORMATION DISCLOSURE STATEMENT

Box - IDS

Commissioner for Patents

Washington, D.C. 20231


Sir:

Pursuant to the duty of disclosure in accordance with 37 C.F.R. §1.56, Applicant wishes to bring to the attention of the Examiner the items of information listed on the enclosed Information Disclosure Citation Form. This information has not been previously submitted in this application, and has not been cited previously by the Examiner. Copies of cited items are enclosed in accordance with 37 C.F.R. § 1.98.

The filing of this Information Disclosure Statement shall not be construed as an admission that the information cited is, or is considered to be, prior art or material to patentability as defined in §1.56(b).

This Statement is being submitted within three (3) months of the application filing date and prior to the mailing of any Office Action on the merits. It is believed that no fee is required for consideration of the submitted items. Should any fee be required, however, please charge such fee to Deposit Account No. 23-3030, but not to include any payment of issue fees.

Respectfully submitted

By: 

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Applicant's Substitute for 1449A⁷

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

Sheet

1

of

2

Complete if Known

Application Number

Filing Date

First Named Inventor

SHEPARD, Chester L.

Group Art Unit

Examiner Name

Attorney Docket Number

50005-20

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

[illegible]

Examiner
Signature

Date
Considered

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number. ² See attached Kinds of U.S. Patent documents. ³ Enter Office that issued the document, by the two-letter code (WIPO) Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached. ⁷ In-house version of PTO/SB/08A (10-96).

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INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

REPRODUCTION OF PTO FORM 1449

ATTY. DOCKET NO.

50005-20

SERIAL NO.

APPLICANT

SHEPARD, Chester L. et al.

FILING DATE

GROUP

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.